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## INFORMATION DISCLOSURE CITATION

	INFORMATIO	INFORMATION DISCLOSURE CITATION			
Atty. Docket No.	03180.0324	Serial No. 10/602,670	k 50		
Applicants	Shunko MAGOSHI et al.		2 2000		
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Now	Fumio MURAI et al., "Fast proximity effect correction method using a pattern area density map", J. Vac. Sci. Technol. B 10(6), Nov/Dec 1992, pp. 3072-3076				

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